



## Data Sheet

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Customer:

Part No:

Sample No:

Description:

Item No:

CL-3014AD1A-001

3Ø Lamp Amber Color

| Customer |            |          |      |
|----------|------------|----------|------|
| Check    | Inspection | Approval | Date |
|          |            |          |      |

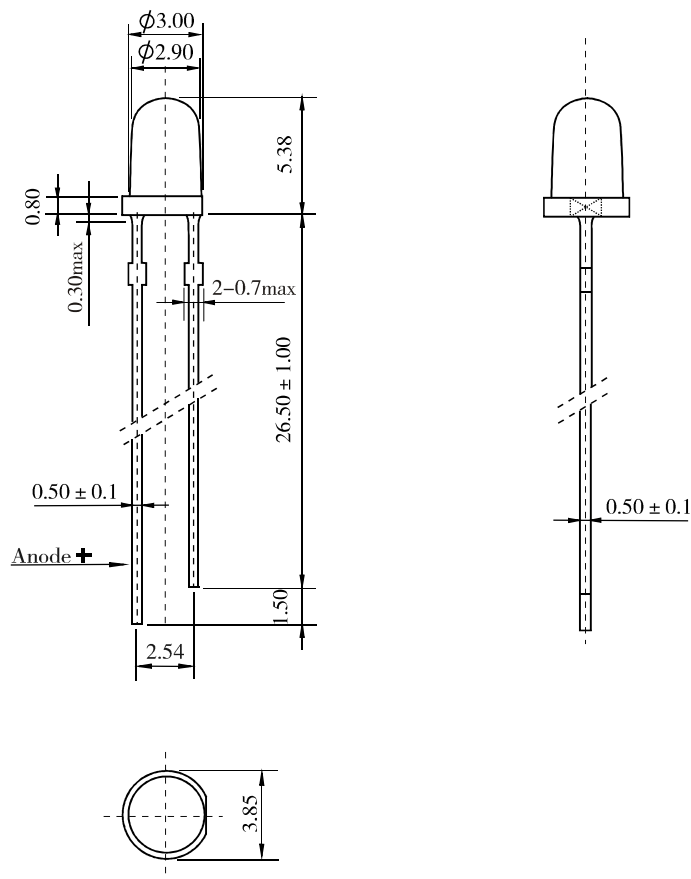
## Features

Low Power Consumption  
High Efficiency  
Round Type  
T1 ( 3mm ) Diameter  
With Flange  
Solder Leads Without Stand-off  
Compliant With RoHS

## Descriptions

Chip Material: AlGaInP/GaAs  
Emitting Color: Ultra Amber  
Lens Color: Orange Diffused

## Outline Drawing



## ATTENTION



OBSERVE PRECAUTIONS  
FOR HANDLING  
ELECTROSTATIC  
SENSITIVE DEVICES

Tolerance is  $\pm 0.25$ mm unless otherwise noted, Unit=mm  
Pin bending  $\leq$  length\*1%

**Electrical Optical Characteristics ( Ta=25℃ )**

| Parameter                | Symbol           | Ultra Amber |     |     | Unit    | Test Condition |
|--------------------------|------------------|-------------|-----|-----|---------|----------------|
|                          |                  | Min         | Typ | Max |         |                |
| Forward Voltage          | $V_F$            | ---         | 2.0 | 2.4 | V       | IF=20mA        |
| Luminous Intensity       | $I_V$            | 145         | 280 | --- | med     | IF=20mA        |
| Peak Wavelength          | $\lambda_P$      | ---         | 612 | --- | nm      | IF=20mA        |
| Dominant Wavelength      | $\lambda_d$      | ---         | 606 | --- | nm      | IF=20mA        |
| Spectral Line half-width | $\Delta \lambda$ | ---         | 20  | --- | nm      | IF=20mA        |
| Reverse Leakage Current  | $I_R$            | ---         | --- | 50  | $\mu A$ | VR=5V          |
| Viewing Angle            | $2\theta_{1/2}$  | ---         | 45  | --- | Deg     | IF=20mA        |

**Absolute Maximum Parameters ( Ta=25℃ )**

| Parameter                   | Symbol    | Condition      | Rating     | Unit |
|-----------------------------|-----------|----------------|------------|------|
| Power Dissipation           | $P_D$     | ---            | 60         | mW   |
| Reverse Voltage             | $V_R$     | ---            | 5          | V    |
| Forward Average Current     | $I_F$     | ---            | 25         | mA   |
| Temperature Coefficient     | I/C       | ---            | 0.33       | mA/℃ |
| Pulse Current               | IFP       | Duty=1/10,1kHz | 100        | mA   |
| Operating Temperature Range | $T_{opr}$ | ---            | -25 ~ +85  | ℃    |
| Storage Temperature Range   | $T_{stg}$ | ---            | -30 ~ +100 | ℃    |
| Soldering Condition         | $T_{sd}$  | ---            | 260℃/5sec  | ℃    |

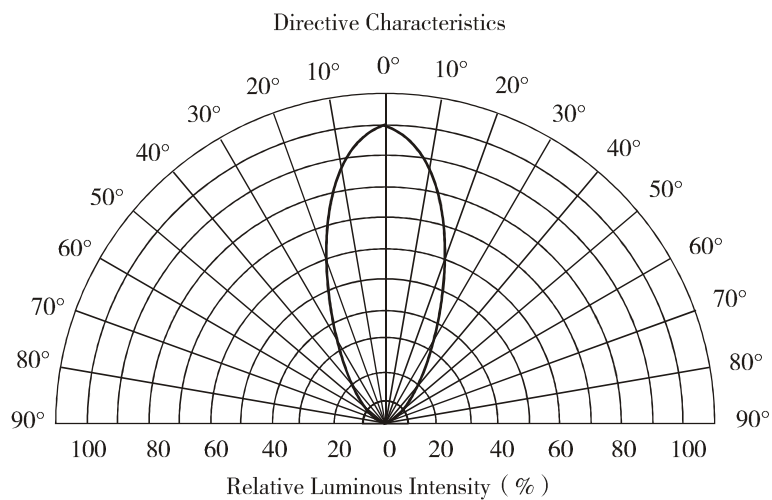
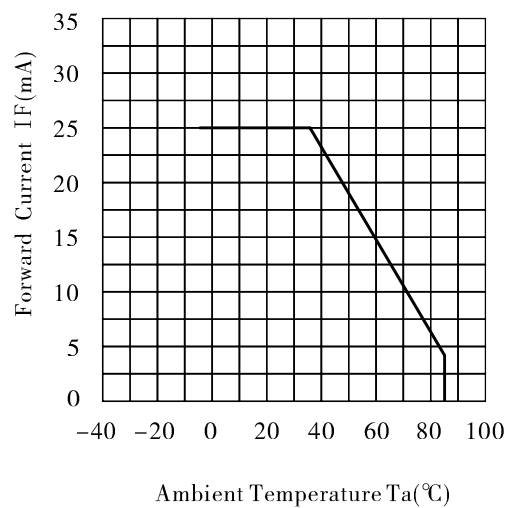
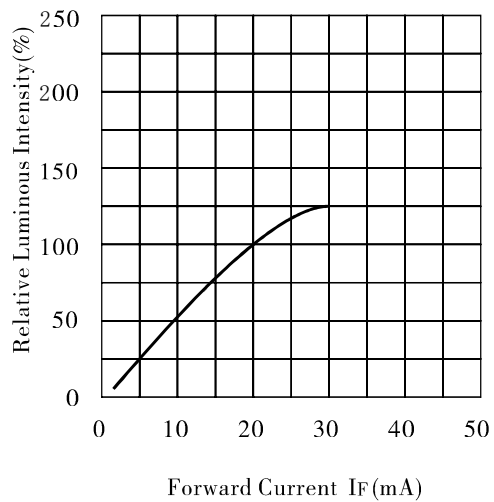
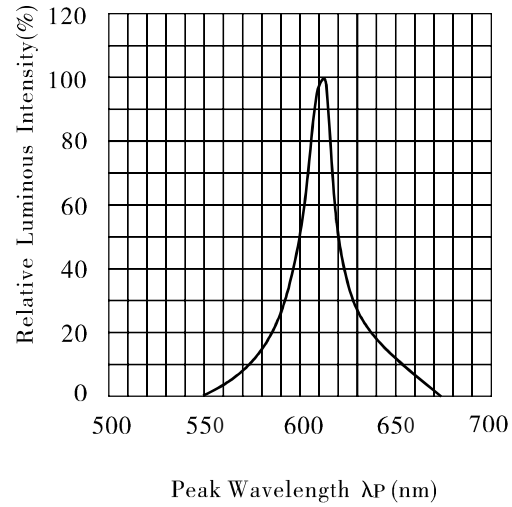
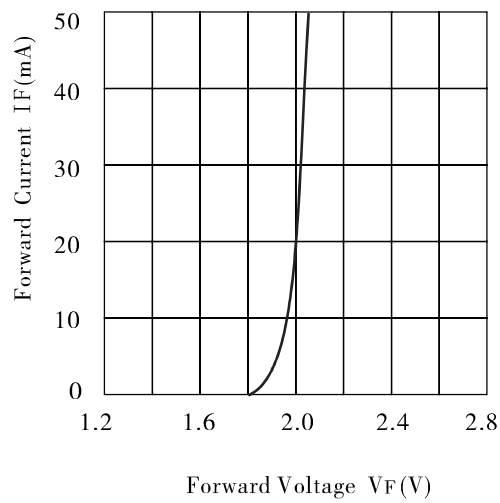
**NOTE:**

Luminous Intensity Measurement allowance is  $\pm 10\%$ .

$2\theta_{1/2}$  is the off-axis angle at which the luminous intensity is half the axial luminous intensity.

The dominant wavelength is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.

### Typical Electro/Optical Characteristic Curves ( $T_a=25^{\circ}\text{C}$ )



### Reliability Test Conditions

| Test Item                                   | Test Condition                             | Result | Judgment Criteria                                                                                                                                      |
|---------------------------------------------|--------------------------------------------|--------|--------------------------------------------------------------------------------------------------------------------------------------------------------|
| Consecutive operating life test             | IF=20mA, T=25℃, t=168h                     | 0/100  | Forward Voltage<br>VF(V)= Upper Limit × 1.2<br>Reverse Leakage Current<br>IR(μA)=Upper Limit × 2.0<br>Luminous Intensity IV<br>(mcd)=Lower Limit × 0.7 |
| High temperature storage life test          | T=100℃, t=168h                             | 0/100  |                                                                                                                                                        |
| Low temperature storage life test           | T=25℃, t=168h                              | 0/100  |                                                                                                                                                        |
| High temperature humidity storage life test | T=85 ± 2℃, RH=85% ± 3, t=168h              | 0/100  |                                                                                                                                                        |
| Temperature cycle test                      | -25℃~25℃~100℃<br>30min 5min 30min 10cycles | 0/100  |                                                                                                                                                        |
| Thermal shock test                          | 100℃ 0℃<br>5min 5min 20cycles              | 0/100  |                                                                                                                                                        |
| Soldering heat test                         | T=260 ± 5℃, t=10s ± 1s                     | 0/100  |                                                                                                                                                        |
| Solderability test                          | T=235 ± 5℃, t=5s ± 0.5s                    | 0/100  | Steeped Part ≥ 95%                                                                                                                                     |
| Fall test                                   | h=100cm, 50times                           | 0/100  | Surface Appearance<br>Photoelectric<br>Properties Intact                                                                                               |
| Terminal strength test                      | W=9.8N, t=30 ± 5s                          | 0/100  |                                                                                                                                                        |
| Lead bending test                           | W=4.9N, 2times                             | 0/100  |                                                                                                                                                        |